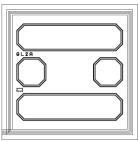
Ultra Low Noise, Medium Current E-PHEMT Transistor Die

TAV2-14LN-D+

50Ω 0.05 to 10 GHz

The Big Deal

- Low Noise Figure, 0.6 dB typ. at 6 GHz, 2V
- High Gain, 16.4 dB typ. at 6 GHz, 4V
- High OIP3, +30.9 dBm typ. at 6 GHz, 4V
- High P1dB, 18.8 dBm typ. at 6 GHz, 4V



Product Overview

Mini-Circuits' TAV2-14LN-D+ is a MMIC E-PHEMT* transistor die with an operating frequency range from 0.05 to 10 GHz. This model combines high gain with extremely low noise figure, resulting in lower overall system noise. Low NF and IP3 performance make it an ideal choice for sensitive receivers in communications systems. This model requires external biasing and matching.

Key Features

Feature	Advantages
Wideband, 0.05 to 10 GHz Usable to 12 GHz	A single device covers many wireless communications bands including cellular, ISM, GSM, WCDMA, WiMax, WLAN, 5G and more.
High IP3 vs. DC power consumption • +30.9 dBm at 6 GHz, 4V • +33.2 dBm at 12 GHz, 4V	 The TAV2-14LN-D+ matches industry leading IP3 performance relative to device size and power consumption. Enhanced linearity over a broad frequency range makes the device ideal for use in: Driver amplifiers for complex waveform up converter paths Drivers in linearized transmit systems
Combines high gain (16.4 dB) with very low Noise Figure (0.7 dB)	The unique combination of high gain and low Noise Figure results in lower overall system noise.
Unpackaged Die	Enables the user to integrate the amplifier directly into hybrids

* Enhancement mode Pseudomorphic High Electron Mobility Transistor.

Ultra Low Noise, Medium Current E-PHEMT Transistor Die

Product Features

- Low Noise Figure, 0.6 dB typ. at 6 GHz, 2V,
- Gain, 16.4 dB typ. at 6 GHz, 4V
- High Output IP3, +30.9 dBm at 6 GHz, 4V
- Output Power at 1dB comp., +18.8 dBm at 6 GHz, 4V
- External biasing and matching required
- Usable to 12 GHz

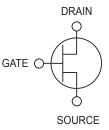
Typical Applications

- 5G
- Cellular
- ISM
- GSM
- WCDMA
- WiMax
- WLAN
- UNII and HIPERLAN

General Description

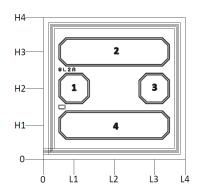
Mini-Circuits' TAV2-14LN-D+ is a MMIC E-PHEMT* transistor die with an operating frequency range from 0.05 to 10 GHz. This model combines high gain with extremely low noise figure, resulting in lower overall system noise. Low NF and IP3 performance make it an ideal choice for sensitive receivers in communications systems. This model requires external biasing and matching.

Simplified Schematic and Pad description



Pad#	Description				
1	GATE used for RF-IN				
2,4 & bottom of die	SOURCE Terminal, connected to ground				
3	DRAIN used for RF-OUT				

Bonding Pad Position



	Dimensions in µm, Typical							
L1	L2	L3	L4	H1	H2	НЗ	H4	
87	200	313	400	97	200	303	400	
Thi	ckness	ness Die size 1 & 3			Pad s 2 &			
	100	400	400 x 400		75	301 x 69		

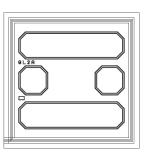
REV. OR ECO-001966 TAV2-14LN-D+ GY/RS/CP 200226 Page 2 of 6

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+RoHS Compliant



TAV2-14LN-D+

Electrical Specifications at T_{AMB}=25°C

Symbol	Parameter	Min.	Тур.	Max.	Units	
		DC Specifications				
V _{TH}	Threshold Voltage	V _{DS} =4V, I _{DS} =4 mA		0.37		V
I _{DSS}	Saturated Drain Current	V _{DS} =4V, V _{GS} =0 V	—	2.0	-	μΑ
G _M	Transconductance	$ \begin{array}{c} V_{_{DS}} = \!$	_	192	_	mS
I _{GSS}	Gate leakage Current	$V_{GD} = V_{GS} = -3V$	—	1.0		μA

	RF &	& DC Specification	ns, Z0=50 Ohms			
Parameter	arameter Condition (GHz) $V_{DS} = 4V^1$, $I_{DS} = 40mA$			$V_{DS} = 2V^1$ $I_{DS} = 20mA$	Units	
		Min.	Тур.	Max.	Тур.	
	0.05		23.4		22	
	6		16.4		15.9	
Gain	8		13.9		13.3	dB
	10		11.8		11.3	
	12		10.2		10	
	0.05		_		_	
	6		7		6	
Input Return Loss	8		7		6	dB
	10		7		7	
	12		8		7	
	0.05		5		5	
	6		13		13	
Output Return Loss	8		20		17	dB
	10		20		17	
	12		19		16	
	0.05		17.7		13.3	
	6		18.8		13.1	
P1dB ²	8		19.1		13.4	dBm
	10		19.4		13.5	
	12		19.1		13	
	0.05		27.1		22.8	
	6		30.9		24.9	
OIP3 Pout=5dBm/Tone	8		31.6		25.9	dBm
Foul=Subin/Tone	10		33.0		28.5	
	12		33.2		29.0	
	0.05		2.5		0.7	
	6		0.7		0.6	
Noise Figure	8		0.7		0.6	dB
-	10		0.8		0.7	
	12		1.0		0.8	
I _{DS}	DC		40		20	mA
V _{GS}	DC	0.44	0.65	0.72	0.58	V

1. Die is packaged in 2x2 mm, 6-lead MCLP package and soldered on TB-TAV2-14LN+. See Fig. 1 2. Drain current bias allowed to increase during compression measurement.

Absolute Maximum Ratings³

Symbol	Parameter	Max.	Units
V _{DS} ⁴	Drain-Source Voltage	5	V
V _{GS} ⁴	Gate-Source Voltage at V _{DS} =4V	-5 &1	V
I_4 DS	Drain Current at V _{DS} =4V	65	mA
lgs	Gate Current	15	μA
P _{DISS}	Total Dissipated Power	325	mW
P _{IN} ⁵	RF Input Power	18 (5-minute max.) 15 (continuous)	dBm
Т _{сн}	Channel Temperature	150	°C
T _{OP}	Operating Temperature	-40 to 85	°C
T _{STD}	Storage Temperature	-65 to 150	°C
θјс	Thermal Resistance	170	°C/W

Operation of this device above any one of these parameters may cause permanent damage.
 Assumes DC quiescent conditions.

5. I_{gs} is limited to 15μ A during test.

Characterization Test Circuit

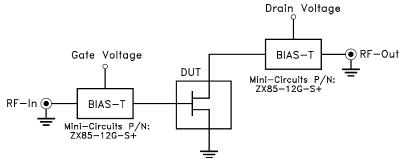


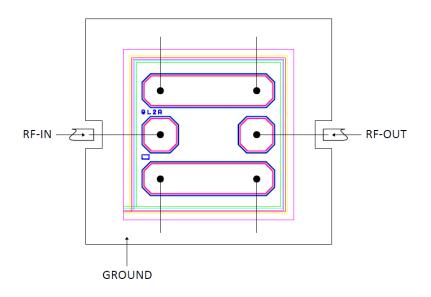
Fig 1. Block Diagram of Test Circuit used for characterization. (DUT is soldered on Mini-Circuits Test Board TB-TAV2-14LN+) Gain, Output power at 1dB compression (P1dB), Noise Figure and output IP3 (OIP3) are measured using Agilent's Microwave Network Analyzer N5242A PNA-X.

Conditions:

- 1. Drain voltage (with reference to source, V_{DS})= 2V&4V as shown.
- 2. Gate Voltage (with reference to source, VGS) is set to obtain desired Drain-Source current (IDS) as shown in graphs or specification table.
- 3. Gain: Pin= -25dBm
- 4. Output IP3 (OIP3): Two tones, spaced 1 MHz apart, 5 dBm/tone at output.
- 5. No external matching components used.



Assembly Diagram



Assembly and Handling Procedure

- 1. Storage
 - Dice should be stored in a dry nitrogen purged desiccators or equivalent.
- 2. ESD

MMIC E-PHEMT transistor dice are susceptible to electrostatic and mechanical damage. Die are supplied in antistatic protected material, which should be opened in clean room conditions at an appropriately grounded anti-static worksta tion. Devices need careful handling using correctly designed collets, vacuum pickup tips or sharp antistatic tweezers to deter ESD damage to dice.

3. Die Attach

The die mounting surface must be clean and flat. Using conductive silver filled epoxy, recommended epoxies are DieMat DM6030HK-PT/H579 or Ablestik 84-1LMISR4. Apply sufficient epoxy to meet required epoxy bond line thickness, epoxy fillet height and epoxy coverage around total die periphery. Parts shall be cured in a nitrogen filled atmosphere per manufacturer's cure condition. It is recommended to use antistatic die pick up tools only.

4. Wire Bonding

Bond pad openings in the surface passivation above the bond pads are provided to allow wire bonding to the dice gold bond pads. Thermosonic bonding is used with minimized ultrasonic content. Bond force, time, ultrasonic power and temperature are all critical parameters. Suggested wire is pure gold, 1 mil diameter. Bonds must be made from the bond pads on the die to the package or substrate. All bond wires should be kept as short as low as reasonable to minimize performance degradation due to undesirable series inductance.

TAV2-14LN-D+

Additional Detailed Technical Information

additional information is available on our dash board.

	Data Table					
Performance Data	Swept Graphs					
	S-Parameter (S2P Files) Data Set					
Case Style	Die					
	Quantity, Package	Model No.				
Die Ordering and packaging	Small, Gel - Pak: 5,10,50,100 KGD* Medium [†] , Partial wafer: KGD*<3721 Large [†] , Full Wafer	TAV2-14LN-DG+ TAV2-14LN-DP+ TAV2-14LN-DF+				
	[†] Available upon request contact sales	representative				
	Refer to AN-60-067					
Environmental Ratings	ENV80					

*Known Good Dice ("KGD") means that the dice in question have been subjected to Mini-Circuits DC test performance criteria and measurement instructions and that the parametric data of such dice fall within a predefined range. While DC testing is not definitive, it does help to provide a higher degree of confidence that dice are capable of meeting typical RF electrical parameters specified by Mini-Circuits.

ESD Rating**

Human Body Model (HBM): Class 0 (pass 50V) in accordance with ANSI/ESD STM 5.1 - 2001

** Tested in industry standard 2x2 mm, 6-Lead MCLP package.

Additional Notes

- A. Performance and quality attributes and conditions not expressly stated in this specification document are intended to be excluded and do not form a part of this specification document.
- B. Electrical specifications and performance data contained in this specification document are based on Mini-Circuit's applicable established test performance criteria and measurement instructions.
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MMIC Amplifier Die

Typical Performance Data

Definitions:

Input Return Loss = -S11 (dB) Gain(Power Gain) = S21 (dB) Reverse Isolation = -S12 (dB) Output Return Loss = -S22 (dB)

TEST CONDITIONS: Vd = 2.00V, Id = 20mA @ Temperature = +25°C

FREQ	Gain	Isolation	Input Return Loss	Output Return Loss	Stal	bility	IP-3 Output	1dB Comp. Output	Noise Figure
(MHz)	(dB)	(dB)	(dB)	(dB)	к	Measure	(dBm)	(dBm)	(dB)
100	22.12	51.36	0.00	4.38	0.01	1.27	24.22	13.03	0.65
200	22.10	45.16	0.02	4.41	0.03	1.27	24.10	12.96	0.58
300	22.06	41.41	0.04	4.44	0.06	1.27	24.38	13.24	0.64
400	22.01	39.22	0.07	4.47	0.06	1.27	24.50	12.81	0.69
500	21.95	37.29	0.11	4.52	0.09	1.26	24.04	12.88	0.68
1000	21.55	31.62	0.44	4.84	0.18	1.23	23.41	13.30	0.64
2000	20.28	26.75	1.44	5.77	0.34	1.14	23.19	12.84	0.67
3000	18.93	24.38	2.51	6.64	0.47	1.07	23.52	12.67	0.76
4000	17.82	22.73	3.60	7.68	0.57	1.01	23.67	12.76	0.72
5000	16.89	21.36	4.77	9.38	0.67	0.97	23.76	13.15	0.67
6000	15.88	20.35	5.89	12.39	0.78	0.95	25.45	13.20	0.75
7000	14.66	19.78	6.45	16.16	0.88	0.97	26.32	13.41	0.81
8000	13.39	19.40	6.55	17.80	0.97	1.00	26.56	13.41	0.83
9000	12.28	18.91	6.72	17.59	1.03	1.01	28.24	13.73	0.80
10000	11.37	18.29	7.12	17.44	1.07	1.00	28.98	13.52	0.78
11000	10.54	17.64	7.57	17.37	1.12	0.98	27.83	13.64	0.99
12000	9.70	17.04	7.48	16.35	1.15	0.97	29.89	13.33	1.01
13000	8.77	16.53	6.94	14.92	1.17	0.98	27.54	13.20	1.02
14000	7.89	15.98	6.59	14.26	1.19	0.99	30.01	13.42	1.13
15000	7.22	15.23	6.72	14.60	1.20	0.98	30.88	13.61	1.21
16000	6.66	14.35	7.07	15.31	1.19	0.96	30.61	13.91	1.37
17000	6.08	13.47	7.17	14.83	1.18	0.93	30.15	13.71	1.13
18000	5.36	12.71	6.87	12.99	1.17	0.90	32.36	13.46	1.27
19000	4.51	12.04	6.35	11.28	1.15	0.88	33.58	12.72	1.57
20000	3.65	11.35	5.98	10.19	1.14	0.86	34.36	12.55	2.00

Note: Test data of Die packaged in industry standard 2x2 mm, 6-lead MCLP package





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IF/RF MICROWAVE COMPONENTS

MMIC Amplifier Die

Typical Performance Data

Definitions:

Input Return Loss = -S11 (dB) Gain(Power Gain) = S21 (dB) Reverse Isolation = -S12 (dB) Output Return Loss = -S22 (dB)

TEST CONDITIONS: Vd = 4.00V, Id = 40mA @ Temperature = +25°C

FREQ	Gain	Isolation	Input Return Loss	Output Return Loss	Stability		IP-3 Output	1dB Comp. Output	Noise Figure
(MHz)	(dB)	(dB)	(dB)	(dB)	К	Measure	(dBm)	(dBm)	(dB)
100	23.49	51.66	0.05	5.77	0.13	1.46	27.30	17.57	1.76
200	23.46	45.86	0.06	5.80	0.08	1.46	27.55	17.67	1.26
300	23.42	42.17	0.09	5.82	0.09	1.45	28.09	17.75	1.18
400	23.36	39.63	0.13	5.85	0.11	1.45	28.38	17.71	1.09
500	23.30	37.76	0.18	5.90	0.12	1.44	28.17	17.77	0.99
1000	22.84	32.16	0.55	6.28	0.22	1.38	27.94	17.68	0.85
2000	21.44	27.33	1.70	7.34	0.39	1.23	28.44	17.76	0.83
3000	19.98	24.90	2.90	8.30	0.53	1.10	28.90	17.89	0.90
4000	18.75	23.13	4.12	9.46	0.64	1.00	29.48	18.10	0.88
5000	17.70	21.68	5.38	11.40	0.73	0.93	30.06	18.60	0.86
6000	16.57	20.64	6.53	14.82	0.83	0.89	31.04	18.90	0.88
7000	15.28	19.94	6.99	17.90	0.92	0.89	31.45	19.17	1.01
8000	13.97	19.40	7.00	17.42	0.99	0.91	31.89	19.13	0.95
9000	12.85	18.81	7.15	16.75	1.03	0.92	32.75	19.52	0.92
10000	11.92	18.07	7.57	16.77	1.06	0.91	33.27	19.39	0.96
11000	11.08	17.35	8.03	16.55	1.10	0.89	33.34	19.47	1.18
12000	10.21	16.69	7.89	15.19	1.12	0.88	33.45	19.19	1.25
13000	9.27	16.16	7.29	13.57	1.14	0.88	33.58	19.07	1.22
14000	8.37	15.57	6.91	12.90	1.15	0.89	34.26	19.27	1.20
15000	7.68	14.82	7.06	13.23	1.16	0.89	35.11	19.38	1.49
16000	7.10	13.95	7.45	13.89	1.16	0.87	34.37	19.68	1.58
17000	6.50	13.11	7.56	13.53	1.15	0.84	33.98	19.37	1.58
18000	5.75	12.39	7.24	11.99	1.14	0.81	35.90	18.07	1.61
19000	4.88	11.77	6.68	10.53	1.13	0.80	35.96	16.95	2.01
20000	4.00	11.12	6.28	9.61	1.13	0.79	36.53	13.85	2.33

Note: Test data of Die packaged in industry standard 2x2 mm, 6-lead MCLP package

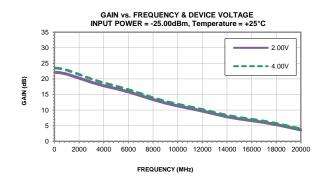


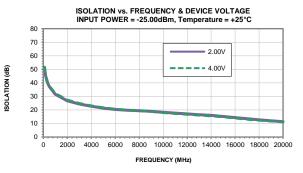


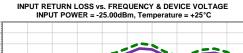
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Typical Performance Curves

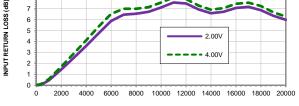




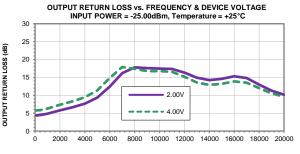


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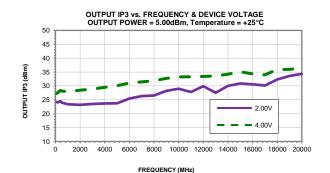
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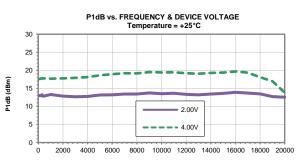


FREQUENCY (MHz)



FREQUENCY (MHz)







NOISE FIGURE vs. FREQUENCY & DEVICE VOLTAGE Temperature = +25°C 5.0 4.5 4.0 2.00V 3.5 NOISE FIGURE (dB) • 4.00V 3.0 2.5 2.0 1.5 1.0 0.5 0.0 0 2000 4000 6000 8000 10000 12000 14000 16000 18000 20000

FREQUENCY (MHz)

Note: Test data of Die packaged in industry standard 2x2 mm, 6-lead MCLP package



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Specification	Test/Inspection Condition	Reference/Spec
Operating Temperature	-40° to 85° C or -40° to 105° C or -55° to 105° C or -45° to 105° C Ambient Environment	Refer to Individual Model Data Sheet
Storage Environment (Die)	-65° to 150°C	Individual Model Data Sheet
Storage Environment(Packaging)	-40° to 70°C and 40 to 60% humidity (In Factory Shipped Package)	

ENV80 Rev: C 06/10/24 DCO-1455 File: ENV80.pdf

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